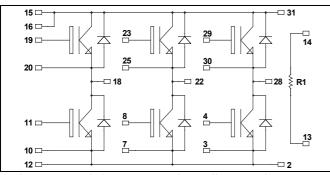
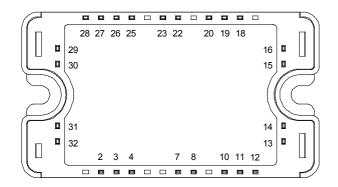


# 3 Phase bridge NPT IGBT Power Module





It is recommended to connect a decoupling capacitor between pins 31 & 2 to reduce switching overvoltages, if DC Power is connected between pins 15, 16 & 12. Pins 15 & 16 must be shorted together.



#### **Application**

Motor control

#### **Features**

- Non Punch Through (NPT) Fast IGBT
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 100 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

#### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS compliant

#### Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
$V_{CES}$	Collector - Emitter Breakdown Voltage		600	V
Ţ	Continuous Collector Current	$T_C = 25^{\circ}C$	65	
$I_{\rm C}$	Continuous Conector Current	$T_C = 80$ °C	50 *	A
$I_{CM}$	Pulsed Collector Current	$T_C = 25$ °C	230	
$V_{GE}$	Gate – Emitter Voltage		±20	V
$P_{D}$	Maximum Power Dissipation	$T_C = 25^{\circ}C$	250	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 125$ °C	100A @ 500V	

<sup>\*</sup> Specification of IGBT device but output current must be limited to 40A at Tc=80°C not to exceed a connectors temperature greater than 120°C.

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



### All ratings @ $T_j = 25$ °C unless otherwise specified

### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
T	Zero Gate Voltage Collector Current	$V_{GE} = 0V$	$T_j = 25$ °C			250	μA
$I_{CES}$	Zero Gate voltage Collector Current	$V_{CE} = 600V$	$T_j = 125$ °C			500	μΑ
V	Collector Emitter Saturation Voltage	$V_{GE} = 15V$	$T_j = 25$ °C	1.7	2.0	2.45	V
$V_{CE(sat)}$	Conector Emitter Saturation Voltage	$I_C = 50A$	$T_j = 125$ °C		2.2		v
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 1 \text{mA}$		4		6	V
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE}$	$V_{GE} = 20V$ , $V_{CE} = 0V$			400	nA

**Dynamic Characteristics** 

v	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$			2200		pF
$C_{oes}$	Output Capacitance	$V_{CE} = 25V$			323		
$C_{res}$	Reverse Transfer Capacitance	f = 1MHz			200		
$Q_{g}$	Total gate Charge	$V_{GE} = 15V$			166		
$Q_{ge}$	Gate – Emitter Charge	$V_{Bus} = 300V$			20		nC
$Q_{gc}$	Gate – Collector Charge	$I_C = 50A$			100		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C)			40		
$T_{\rm r}$	Rise Time	$V_{GE} = 15V$			9		
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 400V$ $I_{\text{C}} = 50A$ $R_{\text{G}} = 2.7\Omega$			120		ns
$T_{\mathrm{f}}$	Fall Time				12		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C)			42		
$T_{\rm r}$	Rise Time	$V_{GE} = 15V$			10		ĺ
$T_{d(off)}$	Turn-off Delay Time	$V_{\text{Bus}} = 400V$ $I_{\text{C}} = 50A$			130		ns
$T_{\rm f}$	Fall Time	$R_G = 2.7\Omega$			21		
Eon	Turn-on Switching Energy	$V_{GE} = 15V$ $V_{Bus} = 400V$	$T_j = 125$ °C		0.5		m I
$E_{\text{off}}$	Turn-off Switching Energy	$I_C = 50A$ $R_G = 2.7\Omega$	$T_j = 125$ °C		1		mJ

Reverse diode ratings and characteristics

Symbol	Characteristic	Test Conditions	Test Conditions		Typ	Max	Unit
$V_{RRM}$	Maximum Peak Repetitive Reverse Voltage			600			V
$I_{RM}$	Maximum Reverse Leakage Current	V -600V	$T_j = 25^{\circ}C$			25	۸
1 <sub>RM</sub>	Waximum Reverse Leakage Current	$V_R=600V$	$T_{j} = 125^{\circ}C$			500	μA
$I_F$	DC Forward Current		Tc = 80°C		30		A
	Diode Forward Voltage	$I_F = 30A$			1.8	2.2	
$V_{\mathrm{F}}$		$I_F = 60A$			2.2		V
		$I_F = 30A$	$T_j = 125$ °C		1.5		
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 30A$ $V_R = 400V$	$T_j = 25$ °C		25		ns
crr	Reverse Recovery Time		$T_{j} = 125^{\circ}C$		160		115
Q <sub>rr</sub>	Reverse Recovery Charge	$\frac{V_R}{di/dt} = 200A/\mu s$	$T_j = 25$ °C		35		nC
			$T_j = 125$ °C		480		iic



 $Temperature \ sensor \ NTC \ (\text{see application note APT0406 on www.microsemi.com for more information}). \\$ 

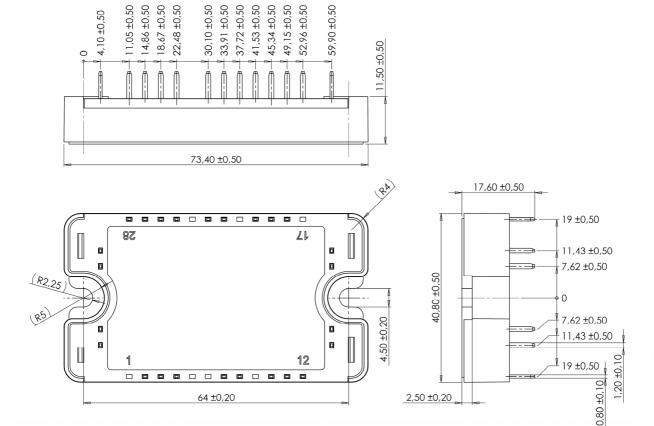
Symbol	Characteristic	Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K

$$R_T = \frac{R_{25}}{\exp \left[ \frac{1}{R_{25/85}} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \text{T: Thermistor temperature}$$
 
$$R_T: \text{ Thermistor value at T}$$

Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit	
$R_{thJC}$	Junction to Case Thermal Resistance		IGBT			0.5	°C/W	
		Diode			1.2	C/ W		
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz		2500			V		
$T_{J}$	Operating junction temperature range			-40		150	150	
$T_{STG}$	Storage Temperature Range		-40		125	°C		
$T_{\rm C}$	Operating Case Temperature		-40		100			
Torque	Mounting torque	To heatsink	M4	2		3	N.m	
Wt	Package Weight					110	g	

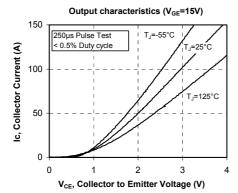
#### SP3 Package outline (dimensions in mm)

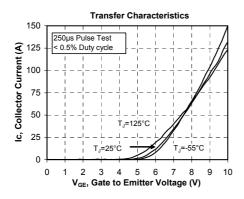


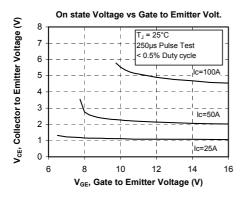
See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

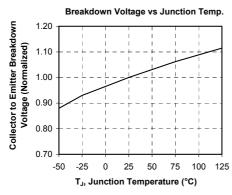


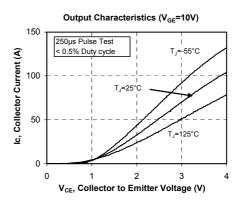
### **Typical Performance Curve**

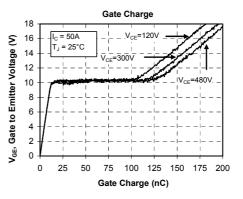


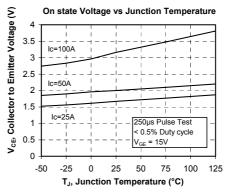


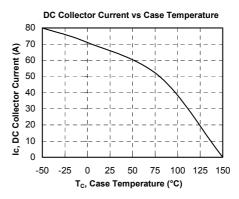




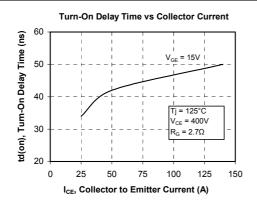


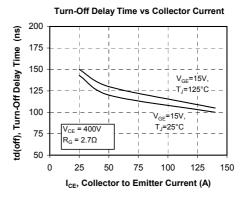


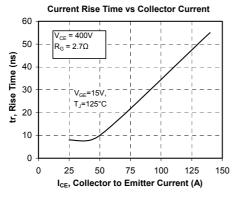


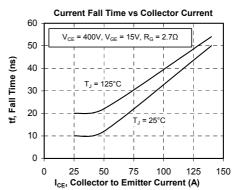


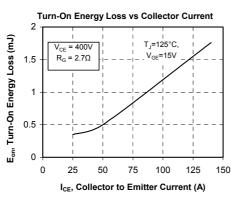


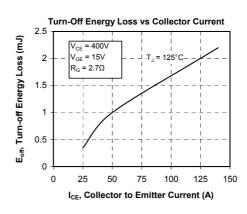


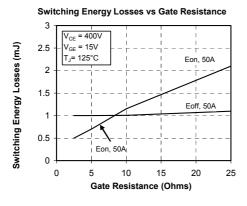


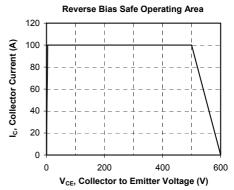




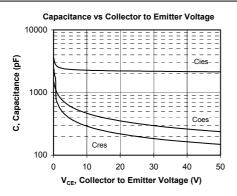


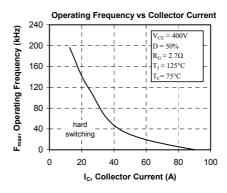


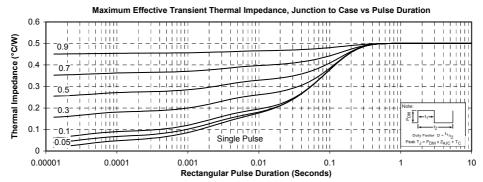














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